S	earch	Notes	

Application/C	ontrol No.	Applicant(s)/Patent under Reexamination	
10/717,359		NAG, SUDIP K.	
Examiner		Art Unit	
Vutha Siak		2825	

SEARCHED				
Class	Subclass	Date	Examiner	
716	6	7/1/2705	vs	
716	5-6,12-14	8/29/06	vs	
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INTERFERENCE SEARCHED			
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716	5-6,12-14	8/29/06	y
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SEARCH NOT (INCLUDING SEARCH		)
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EAST (ALL DATABASES) (See Search History Printout)	7/27/2005	vs
undated Segrch EAST: IEEE; ACM See printonts	8/29/06	V5
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